Features

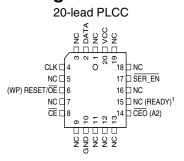
- EE Programmable 65,536 x 1-, 131,072 x 1-, and 262,144 x 1-bit Serial Memories
 Designed to Store Configuration Programs for Field Programmable Gate
 Arrays (FPGAs)
- In-System Programmable (ISP) via 2-wire Bus
- Simple Interface to SRAM FPGAs
- Compatible with Atmel AT6000, AT40K FPGAs, Altera FLEX[®], APEX[™] Devices, Lucent ORCA[®] FPGAs, Xilinx XC3000[™], XC4000[™], XC5200[™], Spartan[®], Virtex[™] FPGAs, Motorola MPA1000 FPGAs
- Cascadable Read-back to Support Additional Configurations (128K and 256K Only)
- Low-power CMOS EEPROM Process
- Programmable Reset Polarity
- Available in the Space-efficient Plastic DIP or SOIC Packages; PLCC Package is Pin-compatible across Product Family
- Emulation of Atmel's AT24CXXX Serial EEPROMs
- Available in 3.3V ± 10% LV and 5V ± 5% C Versions
- · Low-power Standby Mode

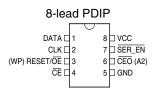
Description

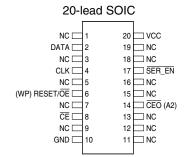
The AT17C65/128/256 and AT17LV65/128/256 (low-density AT17 series) FPGA configuration EEPROMs (configurators) provide an easy-to-use, cost-effective configuration memory for field programmable gate arrays. The low-density AT17 series is packaged in the 8-lead PDIP, 8-lead SOIC and the popular 20-lead PLCC and SOIC. The AT17 series family uses a simple serial-access procedure to configure one or more FPGA devices. The AT17 series organization supplies enough memory to configure one or multiple smaller FPGAs. Using a feature of the AT17 series, the user can select the polarity of the reset function by programming a special EEPROM byte. These devices also support a write-protection mechanism within its programming mode.

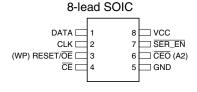
The AT17 Series Configurators can be programmed with industry-standard programmers, or Atmel's ATDH2200E Programming Kit.

Pin Configurations









Note: 1. READY pin is available on new parts only. See page 12.





FPGA Configuration EEPROM Memory

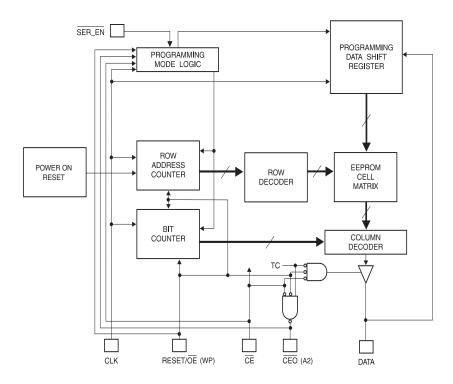
64K, 128K and 256K

AT17C65 AT17LV65 AT17C128 AT17LV128 AT17C256 AT17LV256

Rev. 1636C-04/01



Block Diagram



FPGA Master Serial Mode Summary

The I/O and logic functions of the FPGA and their associated interconnections are established by a configuration program. The program is loaded either automatically upon power-up, or on command, depending on the state of the FPGA mode pins. In Master Mode, the FPGA automatically loads the configuration program from an external memory. The AT17 Serial Configuration EEPROM has been designed for compatibility with the Master Serial Mode.

This document discusses the AT6000 FPGA interface and shows circuits for AT40K and Xilinx applications.

Controlling the Low-density AT17 Series Serial EEPROMs During Configuration

Most connections between the FPGA device and the AT17 Serial EEPROM are simple and self-explanatory.

- The DATA output of the AT17 Series Configurator drives DIN of the FPGA devices.
- The master FPGA CCLK output drives the CLK input of the AT17 Series Configurator.

- The CEO output of any AT17C/LV128/256 drives the CE input of the next AT17C/LV128/256 in a cascade chain of EEPROMs. An AT17C/LV65 can only be used at the end of a cascade chain or as a standalone device.
- SER_EN must be connected to VCC (except during ISP). See the "Configurator Programming Specification" for details on ISP.

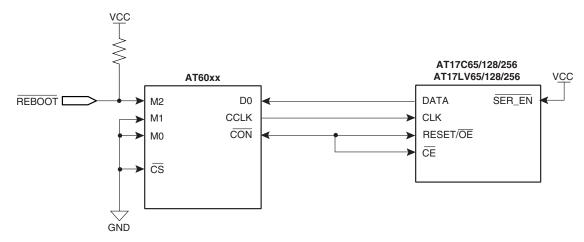
There are two different ways to use the inputs \overline{CE} and \overline{OE} .

Condition 1

The simplest connection is to have the FPGA $\overline{\text{CON}}$ pin drive both $\overline{\text{CE}}$ and RESET/ $\overline{\text{OE}}^{(1)}$ in parallel (Figure 1). Due to its simplicity, however, this method will fail if the FPGA receives an external reset condition during the configuration cycle. If a system reset is applied to the FPGA, it will abort the original configuration and then reset itself for a new configuration, as intended. Of course, the AT17 Series Configurator does not see the external reset signal and will not reset its internal address counters and, consequently, will remain out of sync with the FPGA for the remainder of the configuration cycle.

Note: 1. For this condition, the reset polarity of the EEPROM must be set active High.

Figure 1. Condition 1 Connection



Notes: 1. $4.7 \text{ k}\Omega$ resistors used unless otherwise specified.

2. Reset polarity of EEPROM must be set active High.

Condition 2 (for AT6000)

The FPGA $\overline{\text{CON}}$ pin drives only the $\overline{\text{CE}}$ input of the AT17 Series Configurator, while the RESET/ $\overline{\text{OE}}$ input is driven by an input to the FPGA $\overline{\text{RESET}}$ input pin. This connection works under all normal circumstances, even when the user aborts a configuration before $\overline{\text{CON}}$ has gone High. A low level on the RESET/ $\overline{\text{OE}}^{(1)}$ input – during FPGA reset – clears the configurator's internal address pointer, so that the reconfiguration starts at the beginning.

Note: 1. For this condition, the reset polarity of the EEPROM must be set active Low.

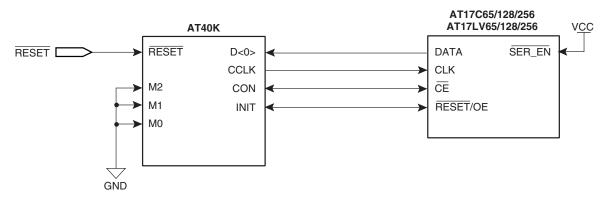
The AT17 Series Configurator does not require an inverter for either condition since the RESET polarity is programmable.

Condition 2 (for AT40K/Xilinx/Altera FPGAs)

The FPGA $\overline{\text{CON}}$ output drives only the $\overline{\text{CE}}$ input of the AT17 Series Configurator, while the $\overline{\text{RESET}}/\text{OE}$ input is driven by the FPGA $\overline{\text{INIT}}$ pin (Figure 2). The equivalent of the $\overline{\text{INIT}}$ pin for Altera devices is nSTATUS. This connection works under all normal circumstances, even when the user aborts the configuration before $\overline{\text{CON}}$ has gone High. A low level on the $\overline{\text{RESET}}/\text{OE}^{(1)}$ input – during FPGA reset – clears the configurator's internal address pointer so that the reconfiguration starts at the beginning.

Note: 1. For this condition, the reset polarity of the EEPROM must be set active Low.

Figure 2. Condition 2 Connection



Notes: 1. $4.7 \text{ k}\Omega$ resistors used unless otherwise specified.

2. Reset polarity must be set to active Low.





Cascading Serial Configuration EEPROMs (AT17C/LV128 and AT17C/LV256 only)⁽¹⁾

For multiple FPGAs configured as a daisy-chain, or for FPGAs requiring larger configuration memories, cascaded configurators provide additional memory.

After the last bit from the first configurator is read, the next clock signal to the configurator asserts its $\overline{\text{CEO}}$ output low and disables its DATA line driver. The second configurator recognizes the low level on its $\overline{\text{CE}}$ input and enables its DATA output.

After configuration is complete, the address counters of all cascaded configurators are reset if the RESET/OE on each configurator is driven to its active (default High) level.

If the address counters are not to be reset upon completion, then the RESET/OE input can be tied to its inactive (default Low) level.

Note:

 A single AT17C/LV65 may be used at the end of a cascade chain.

AT17 Series Reset Polarity

The AT17 Series Configurator allows the user to program the reset polarity as either RESET/OE or RESET/OE. This feature is supported by industry-standard programmer algorithms. For more details on programming the EEPROM's reset polarity, please reference the "Programming Specification for Atmel's FPGA Configuration EEPROMs" application note.

Programming Mode

The programming mode is entered by bringing SER_EN Low. In this mode the chip can be programmed by the 2-wire serial bus. The programming is done at VCC supply only. Programming super voltages are generated inside the chip. See the "Programming Specification for Atmel's FPGA Configuration EEPROMs" application note for further information. The AT17C parts are read/write at 5V nominal. The AT17LV parts are read/write at 3.3V nominal.

Standby Mode

The AT17C/LV65/128/256 enters a low-power standby mode whenever $\overline{\text{CE}}$ is asserted High. In this mode, the configurator consumes less than 75 μA of current at 5.0V. The output remains in a high-impedance state regardless of the state of the $\overline{\text{OE}}$ input.

Pin Configurations

| 20 PLCC/ SOIC | 8 DIP/ SOIC | | | |
|---|-------------------|--|-----|--|
| Pin | Pin | Name | I/O | Description |
| 2 | 1 | DATA | I/O | Three-state DATA output for configuration. Open-collector bi-directional pin for programming. |
| 4 | 2 | CLK | I | Clock input. Used to increment the internal address and bit counter for reading and programming. |
| 6 | 3 | RESET/OE | I | RESET/Output Enable input (when SER_EN is High). A Low level on both the CE and RESET/OE inputs enables the data output driver. A High level on RESET/OE resets both the address and bit counters. The logic polarity of this input is programmable as either RESET/OE or RESET/OE. This document describes the pin as RESET/OE. |
| WP I Write protect (WP) input (when \overline{CE} is Low) be written. When WP is enabled (High), the written. This feature is only active in the 2-v | | Write protect (WP) input (when $\overline{\text{CE}}$ is Low). When WP is Low, the entire memory can be written. When WP is enabled (High), the lowest block of the memory cannot be written. This feature is only active in the 2-wire serial Programming Mode (i.e., when $\overline{\text{SER}_\text{EN}}$ is Low; see "Programming Specification" application note for more details). | | |
| 8 | 4 | CE | I | Chip Enable input. Used for device selection. A Low level on both $\overline{\text{CE}}$ and $\overline{\text{OE}}$ enables the data output driver. A High level on $\overline{\text{CE}}$ disables both the address and bit counters and forces the device into a low-power standby mode. Note that this pin will <i>not</i> enable/disable the device in the 2-wire Serial Programming Mode (i.e., when $\overline{\text{SER}}_{=}\overline{\text{EN}}$ is Low). |
| 10 | 5 | GND | | Ground pin. A 0.2 μF decoupling capacitor between VCC and GND is recommended. |
| 14 | 6 | CEO | 0 | Chip Enable Output. This signal is asserted Low on the clock cycle following the last bit read from the memory. It will stay Low as long as $\overline{\text{CE}}$ and $\overline{\text{OE}}$ are both Low. It will then follow $\overline{\text{CE}}$ until $\overline{\text{OE}}$ goes High. Thereafter, $\overline{\text{CEO}}$ will stay High until the entire EEPROM is read again. |
| | | A2 | I | Device selection input, A2. This is used to enable (or select) the device during programming (i.e., when SER_EN is Low; see the "Programming Specification" application note for more details. |
| 17 | 7 | SER_EN | I | Serial enable must be held High during FPGA loading operations. Bringing SER_EN Low enables the 2-wire Serial Programming Mode. |
| 20 | 8 | VCC | | +3.3V/+5V Power Supply Pin |

Absolute Maximum Ratings*

| _ | |
|---|--|
| | Operating Temperature55°C to +125°C |
| | Storage Temperature65 °C to +150 °C |
| | Voltage on Any Pin with Respect to Ground0.1V to V _{CC} +0.5V |
| | Supply Voltage (V _{CC})0.5V to +7.0V |
| | Maximum Soldering Temp. (10 sec. @ 1/16 in.)260°C |
| | ESD (R _{ZAP} = 1.5K, C _{ZAP} = 100 pF)2000V |

*NOTICE:

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those listed under operating conditions is not implied. Exposure to Absolute Maximum Rating conditions for extended periods of time may affect device reliability.





Operating Conditions

| | | | AT17CXXX | | AT17LVXXX | | |
|-----------------|-------------|--|----------|------|-----------|-----|-------|
| Symbol | Description | | Min | Max | Min | Max | Units |
| | Commercial | Supply voltage relative to GND -0°C to +70°C | 4.75 | 5.25 | 3.0 | 3.6 | V |
| V _{CC} | Industrial | Supply voltage relative to GND -40°C to +85°C | 4.5 | 5.5 | 3.0 | 3.6 | V |
| | Military | Supply voltage relative to GND -55°C to +125°C | 4.5 | 5.5 | 3.0 | 3.6 | V |

DC Characteristics

 V_{CC} = 5V ± 5% Commercial; V_{CC} = 5V ± 10% Industrial/Military

| Symbol | Description | | Min | Max | Units |
|------------------|---|---------------------|-----|-----------------|-------|
| V _{IH} | High-level input voltage | | 2.0 | V _{CC} | V |
| V _{IL} | Low-level input voltage | | 0 | 0.8 | V |
| V _{OH} | High-level output voltage (I _{OH} = -4 mA) | Commonwial | 3.7 | | V |
| V _{OL} | Low-level output voltage (I _{OL} = +4 mA) | Commercial | | 0.32 | V |
| V _{OH} | High-level output voltage (I _{OH} = -4 mA) | | 3.6 | | V |
| V_{OL} | Low-level output voltage (I _{OL} = +4 mA) | Industrial | | 0.37 | V |
| V _{OH} | High-level output voltage (I _{OH} = -4 mA) | NA:III | 3.5 | | V |
| V _{OL} | Low-level output voltage (I _{OL} = +4 mA) | Military | | 0.4 | V |
| I _{CCA} | Supply current, active mode | | | 10 | mA |
| IL | Input or output leakage current ($V_{IN} = V_{CC}$ or GND) | | -10 | 10 | μΑ |
| | Comply assurant standby made | Commercial | | 75 | μA |
| Iccs | Supply current, standby mode | Industrial/Military | | 150 | μA |

DC Characteristics

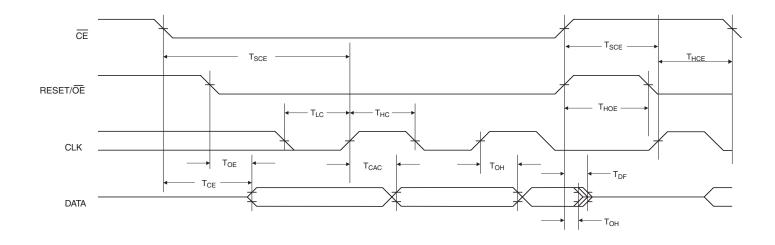
 $V_{CC} = 3.3V \pm 10\%$

| Symbol | Description | | | Max | Units |
|------------------|--|---------------------|-----|-----------------|-------|
| V _{IH} | High-level input voltage | | 2.0 | V _{CC} | V |
| V _{IL} | Low-level input voltage | | 0 | 0.8 | V |
| V _{OH} | High-level output voltage (I _{OH} = -2.5 mA) | Communicial | 2.4 | | V |
| V _{OL} | Low-level output voltage (I _{OL} = +3 mA) | Commercial | | 0.4 | V |
| V _{OH} | High-level output voltage (I _{OH} = -2 mA) | la di satri a l | 2.4 | | V |
| V _{OL} | Low-level output voltage (I _{OL} = +3 mA) | Industrial | | 0.4 | V |
| V _{OH} | High-level output voltage (I _{OH} = -2 mA) | NA:II:4 a m. r | 2.4 | | V |
| V_{OL} | Low-level output voltage (I _{OL} = +2.5 mA) | Military | | 0.4 | V |
| I _{CCA} | Supply current, active mode | | | 5 | mA |
| IL | Input or output leakage current (V _{IN} = V _{CC} or GND) | | -10 | 10 | μA |
| | Complex company atomathy manda | Commercial | | 50 | μΑ |
| I _{CCS} | Supply current, standby mode | Industrial/Military | | 100 | μA |

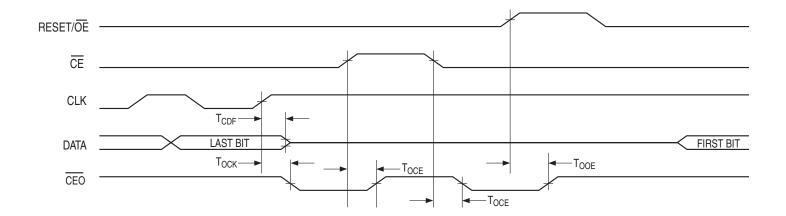




AC Characteristics



AC Characteristics when Cascading



AC Characteristics for AT17C65/128

 $V_{CC} = 5V \pm 5\%$ Commercial; $V_{CC} = 5V \pm 10\%$ Industrial/Military

| | | Comm | nercial | Industrial | /Military ⁽¹⁾ | |
|---------------------------------|---|------|---------|------------|--------------------------|-------|
| Symbol | Description | Min | Max | Min | Max | Units |
| T _{OE} ⁽²⁾ | OE to Data Delay | | 30 | | 35 | ns |
| T _{CE} ⁽²⁾ | CE to Data Delay | | 50 | | 50 | ns |
| T _{CAC} ⁽²⁾ | CLK to Data Delay | | 50 | | 55 | ns |
| T _{OH} | Data Hold from \overline{CE} , \overline{OE} or CLK | 0 | | 0 | | ns |
| T _{DF} ⁽³⁾ | CE or OE to Data Float Delay | | 50 | | 50 | ns |
| T _{LC} | CLK Low Time | 30 | | 35 | | ns |
| T _{HC} | CLK High Time | 30 | | 35 | | ns |
| T _{SCE} | CE Setup Time to CLK (to guarantee proper counting) | 45 | | 50 | | ns |
| T _{HCE} | CE Hold Time from CLK (to guarantee proper counting) | 0 | | 0 | | ns |
| T _{HOE} | OE High Time (guarantees counter is reset) | 25 | | 25 | | ns |
| F _{MAX} | MAX Input Clock Frequency | 12.5 | | 12.5 | | MHz |

AC Characteristics for AT17C128 when Cascading

 V_{CC} = 5V ± 5% Commercial; V_{CC} = 5V ± 10% Industrial/Military

| | | Commercial | | Industrial/Military ⁽¹⁾ | | |
|---------------------------------|---------------------------|------------|-----|------------------------------------|-----|-------|
| Symbol | Description | Min | Max | Min | Max | Units |
| T _{CDF} ⁽³⁾ | CLK to Data Float Delay | | 50 | | 50 | ns |
| T _{OCK} ⁽²⁾ | CLK to CEO Delay | | 55 | | 60 | ns |
| T _{OCE} ⁽²⁾ | CE to CEO Delay | | 55 | | 60 | ns |
| T _{OOE} ⁽²⁾ | RESET/OE to CEO Delay | | 40 | | 45 | ns |
| F _{MAX} | MAX Input Clock Frequency | 8 | | 8 | | MHz |

Notes: 1. Preliminary specifications for military operating range only.

- 2. AC test load = 50 pF.
- 3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady-state active levels.





AC Characteristics for AT17C256

 $V_{CC} = 5V \pm 5\%$ Commercial; $V_{CC} = 5V \pm 10\%$ Industrial/Military

| | | Commercial | | Industrial | /Military ⁽¹⁾ | |
|---------------------------------|---|------------|-----|------------|--------------------------|-------|
| Symbol | Description | Min | Max | Min | Max | Units |
| T _{OE} ⁽²⁾ | OE to Data Delay | | 30 | | 35 | ns |
| T _{CE} ⁽²⁾ | CE to Data Delay | | 45 | | 45 | ns |
| T _{CAC} ⁽²⁾ | CLK to Data Delay | | 50 | | 55 | ns |
| T _{OH} | Data Hold from \overline{CE} , \overline{OE} , or CLK | 0 | | 0 | | ns |
| T _{DF} ⁽³⁾ | CE or OE to Data Float Delay | | 50 | | 50 | ns |
| T _{LC} | CLK Low Time | 20 | | 20 | | ns |
| T _{HC} | CLK High Time | 20 | | 20 | | ns |
| T _{SCE} | CE Setup Time to CLK (to guarantee proper counting) | 35 | | 40 | | ns |
| T _{HCE} | CE Hold Time from CLK (to guarantee proper counting) | 0 | | 0 | | ns |
| T _{HOE} | OE High Time (guarantees counter is reset) | 20 | | 20 | | ns |
| F _{MAX} | MAX Input Clock Frequency | 12.5 | | 12.5 | | MHz |

AC Characteristics for AT17C256 when Cascading

 V_{CC} = 5V ± 5% Commercial; V_{CC} = 5V ± 10% Industrial/Military

| | | Commercial | | Industrial/Military(1) | | |
|---------------------------------|---------------------------|------------|-----|------------------------|-----|-------|
| Symbol | Description | Min | Max | Min | Max | Units |
| T _{CDF} ⁽³⁾ | CLK to Data Float Delay | | 50 | | 50 | ns |
| T _{OCK} ⁽²⁾ | CLK to CEO Delay | | 35 | | 40 | ns |
| T _{OCE} ⁽²⁾ | CE to CEO Delay | | 35 | | 35 | ns |
| T _{OOE} ⁽²⁾ | RESET/OE to CEO Delay | | 30 | | 35 | ns |
| F _{MAX} | MAX Input Clock Frequency | 10 | | 10 | | MHz |

Notes: 1. Preliminary specifications for military operating range only.

^{2.} AC test load = 50 pF.

^{3.} Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady-state active levels.

AC Characteristics for AT17LV65/128/256

 $V_{CC} = 3.3V \pm 10\%$

| | | Comn | Commercial | | l/Military ⁽¹⁾ | |
|---------------------------------|---|------|------------|-----|---------------------------|-------|
| Symbol | Description | Min | Max | Min | Max | Units |
| T _{OE} ⁽²⁾ | OE to Data Delay | | 50 | | 55 | ns |
| T _{CE} ⁽²⁾ | CE to Data Delay | | 60 | | 60 | ns |
| T _{CAC} ⁽²⁾ | CLK to Data Delay | | 75 | | 80 | ns |
| T _{OH} | Data Hold from \overline{CE} , \overline{OE} , or CLK | 0 | | 0 | | ns |
| T _{DF} ⁽³⁾ | CE or OE to Data Float Delay | | 55 | | 55 | ns |
| T _{LC} | CLK Low Time | 25 | | 25 | | ns |
| T _{HC} | CLK High Time | 25 | | 25 | | ns |
| T _{SCE} | TE Setup Time to CLK (to guarantee proper counting) | 35 | | 60 | | ns |
| T _{HCE} | CE Hold Time from CLK (to guarantee proper counting) | 0 | | 0 | | ns |
| T _{HOE} | OE High Time (guarantees counter is reset) | 25 | | 25 | | ns |
| F _{MAX} | MAX Input Clock Frequency | 10 | | 10 | | MHz |

AC Characteristics for AT17LV128/256 when Cascading

 $V_{CC} = 3.3V \pm 10\%$

| | | Commercial | | Industrial/Military(1) | | |
|---------------------------------|---------------------------|------------|-----|------------------------|-----|-------|
| Symbol | Description | Min | Max | Min | Max | Units |
| T _{CDF} ⁽³⁾ | CLK to Data Float Delay | | 60 | | 60 | ns |
| T _{OCK} ⁽²⁾ | CLK to CEO Delay | | 55 | | 60 | ns |
| T _{OCE} ⁽²⁾ | CE to CEO Delay | | 55 | | 60 | ns |
| T _{OOE} ⁽²⁾ | RESET/OE to CEO Delay | | 40 | | 45 | ns |
| F _{MAX} | MAX Input Clock Frequency | 8 | | 8 | | MHz |

Notes: 1. Preliminary specifications for military operating range only.

- 2. AC test lead = 50 pF.
- 3. Float delays are measured with 5 pF AC loads. Transition is measured ±200 mV from steady-state active levels.





Ordering Information – 5V Devices

| Memory Size | Ordering Code | Package | Operation Range |
|-------------|---------------|---------|-----------------|
| 64K | AT17C65-10JC | 20J | Commercial |
| | AT17C65-10PC | 8P3 | (0°C to 70°C) |
| | AT17C65-10SC | 20S | |
| | AT17C65-10NC | 8S1 | |
| | AT17C65-10JI | 20J | Industrial |
| | AT17C65-10PI | 8P3 | (-40°C to 85°C) |
| | AT17C65-10SI | 20\$ | |
| | AT17C65-10NI | 8S1 | |
| 128K | AT17C128-10JC | 20J | Commercial |
| | AT17C128-10PC | 8P3 | (0°C to 70°C) |
| | AT17C128-10SC | 20S | |
| | AT17C128-10NC | 8S1 | |
| | AT17C128-10JI | 20J | Industrial |
| | AT17C128-10PI | 8P3 | (-40°C to 85°C) |
| | AT17C128-10SI | 20S | |
| | AT17C128-10NI | 8S1 | |
| 256K | AT17C256-10JC | 20J | Commercial |
| | AT17C256-10PC | 8P3 | (0°C to 70°C) |
| | AT17C256-10SC | 20S | |
| | AT17C256-10NC | 8S1 | |
| | AT17C256-10JI | 20J | Industrial |
| | AT17C256-10PI | 8P3 | (-40°C to 85°C) |
| | AT17C256-10SI | 20\$ | |
| | AT17C256-10NI | 8S1 | |

Note: For a short period of time there will be two types of low-density configurators. The new version will be identified by a "B" after the date code. Only the "B" version is available in the 8-lead SOIC devices. The "B" version is fully backward-compatible with the original devices so existing customers will not be affected. The new parts no longer require a mux for ISP. See the programming specification for more details.

| Package Type | | |
|--------------|---|--|
| 20J | 20-lead, Plastic J-leaded Chip Carrier (PLCC) | |
| 8P3 | 8-lead, 0.300" Wide, Plastic Dual Inline Package (PDIP) | |
| 20\$ | 20-lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC) | |
| 8S1 | 8-lead, 0.150" Wide, Plastic Gull Wing Small Outline (JEDEC SOIC) | |

Ordering Information – 3.3V Devices

| Memory Size | Ordering Code | Package | Operation Range |
|-------------|----------------|---------|-----------------|
| 64K | AT17LV65-10JC | 20J | Commercial |
| | AT17LV65-10PC | 8P3 | (0°C to 70°C) |
| | AT17LV65-10SC | 20S | |
| | AT17LV65-10NC | 8S1 | |
| | AT17LV65-10JI | 20J | Industrial |
| | AT17LV65-10PI | 8P3 | (-40°C to 85°C) |
| | AT17LV65-10SI | 20\$ | |
| | AT17LV65-10NI | 8S1 | |
| 128K | AT17LV128-10JC | 20J | Commercial |
| | AT17LV128-10PC | 8P3 | (0°C to 70°C) |
| | AT17LV128-10SC | 20S | |
| | AT17LV128-10NC | 8S1 | |
| | AT17LV128-10JI | 20J | Industrial |
| | AT17LV128-10PI | 8P3 | (-40°C to 85°C) |
| | AT17LV128-10SI | 20S | |
| | AT17LV128-10NI | 8S1 | |
| 256K | AT17LV256-10JC | 20J | Commercial |
| | AT17LV256-10PC | 8P3 | (0°C to 70°C) |
| | AT17LV256-10SC | 20S | |
| | AT17LV256-10NC | 8S1 | |
| | AT17LV256-10JI | 20J | Industrial |
| | AT17LV256-10PI | 8P3 | (-40°C to 85°C) |
| | AT17LV256-10SI | 20S | |
| | AT17LV256-10NI | 8S1 | |

Note: 1. For a short period of time there will be two types of low-density configurators. The new version will be identified by a "B" after the date code. Only the "B" version is available in the 8-lead SOIC devices. The "B" version is fully backward-compatible with the original devices so existing customers will not be affected. The new parts no longer require a mux for ISP. See the programming specification for more details.

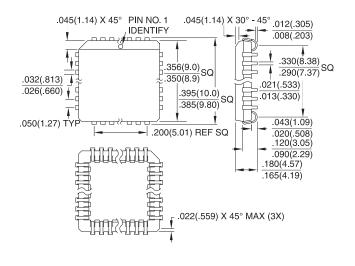
| Package Type | | |
|--------------|---|--|
| 20J | 20-lead, Plastic J-leaded Chip Carrier (PLCC) | |
| 8P3 | 8-lead, 0.300" Wide, Plastic Dual Inline Package (PDIP) | |
| 20\$ | 20-lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC) | |
| 8S1 | 8-lead, 0.150" Wide, Plastic Gull Wing Small Outline (JEDEC SOIC) | |





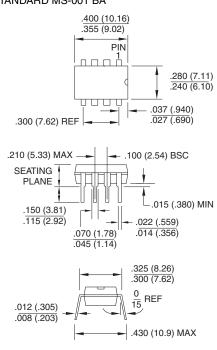
Packaging Information

20J, 20-lead, Plastic J-leaded Chip Carrier (PLCC) Dimensions in Inches and (Millimeters)
JEDEC STANDARD MS-018 AA



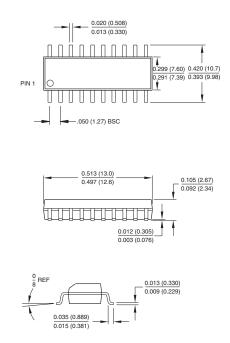
8P3, 8-lead, 0.300" Wide, Plastic Dual Inline Package (PDIP)

Dimensions in Inches and (Millimeters) JEDEC STANDARD MS-001 BA



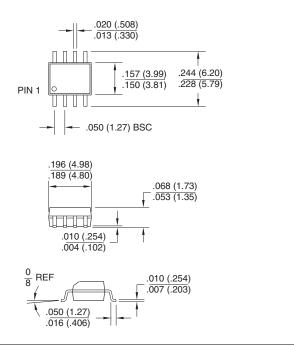
20S, 20-lead, 0.300" Wide, Plastic Gull Wing Small Outline (SOIC)

Dimensions in Inches and (Millimeters)



8S1, 8-lead, 0.150" Wide, Plastic Gull Wing Small Outline (JEDEC SOIC)

Dimensions in Inches and (Millimeters)





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